

Search Notes

Application/Control No.

10/045,393

Examiner

Phuong Phu

Applicant(s)/Patent under
Reexamination

SHIN ET AL.

Art Unit

2631

SEARCHED

Class	Subclass	Date	Examiner
375	292	10/27/05	P ^o
341	58		
	59		
714	800		
	801		
	802		
	803	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
(Same As Above)			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR